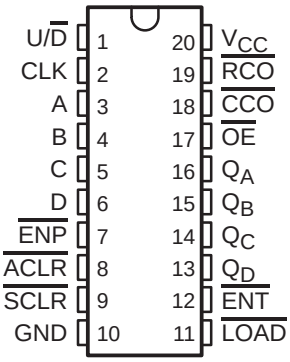
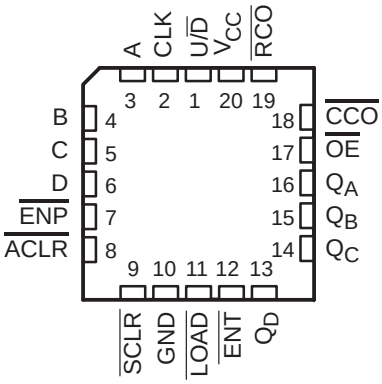
- **3-State Q Outputs Drive Bus Lines Directly**
- **Counter Operation Independent of 3-State Output**
- **Fully Synchronous Clear, Count, and Load**
- **Asynchronous Clear Is Also Provided**
- **Fully Cascadable**
- **Package Options Include Plastic Small-Outline (DW) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) 300-mil DIPs**

SN54ALS569A . . . J PACKAGE
SN74ALS568A, SN74ALS569A . . . DW OR N PACKAGE
(TOP VIEW)



SN54ALS569A . . . FK PACKAGE
(TOP VIEW)



description

The SN74ALS568A decade counter and ′ALS569A binary counters are programmable, count up or down, and offer both synchronous and asynchronous clearing. All synchronous functions are executed on the positive-going edge of the clock (CLK) input.

The clear function is initiated by applying a low level to either asynchronous clear ($\overline{\text{ACLR}}$) or synchronous clear ($\overline{\text{SCLR}}$). Asynchronous (direct) clearing overrides all other functions of the device, while synchronous clearing overrides only the other synchronous functions. Data is loaded from the A, B, C, and D inputs by holding load ($\overline{\text{LOAD}}$) low during a positive-going clock transition. The counting function is enabled only when enable P ($\overline{\text{ENP}}$) and enable T ($\overline{\text{ENT}}$) are low and $\overline{\text{ACLR}}$, $\overline{\text{SCLR}}$, and $\overline{\text{LOAD}}$ are high. The up/down (U/$\overline{\text{D}}$) input controls the direction of the count. These counters count up when U/$\overline{\text{D}}$ is high and count down when U/$\overline{\text{D}}$ is low.

A high level at the output-enable ($\overline{\text{OE}}$) input forces the Q outputs into the high-impedance state, and a low level enables those outputs. Counting is independent of $\overline{\text{OE}}$. $\overline{\text{ENT}}$ is fed forward to enable the ripple-carry output ($\overline{\text{RCO}}$) to produce a low-level pulse while the count is zero (all Q outputs low) when counting down or maximum (9 or 15) when counting up. The clocked carry output ($\overline{\text{CCO}}$) produces a low-level pulse for a duration equal to that of the low level of the clock when $\overline{\text{RCO}}$ is low and the counter is enabled (both $\overline{\text{ENP}}$ and $\overline{\text{ENT}}$ are low); otherwise, $\overline{\text{CCO}}$ is high. $\overline{\text{CCO}}$ does not have the glitches commonly associated with a ripple-carry output. Cascading is normally accomplished by connecting $\overline{\text{RCO}}$ or $\overline{\text{CCO}}$ of the first counter to $\overline{\text{ENT}}$ of the next counter. However, for very high-speed counting, $\overline{\text{RCO}}$ should be used for cascading since $\overline{\text{CCO}}$ does not become active until the clock returns to the low level.

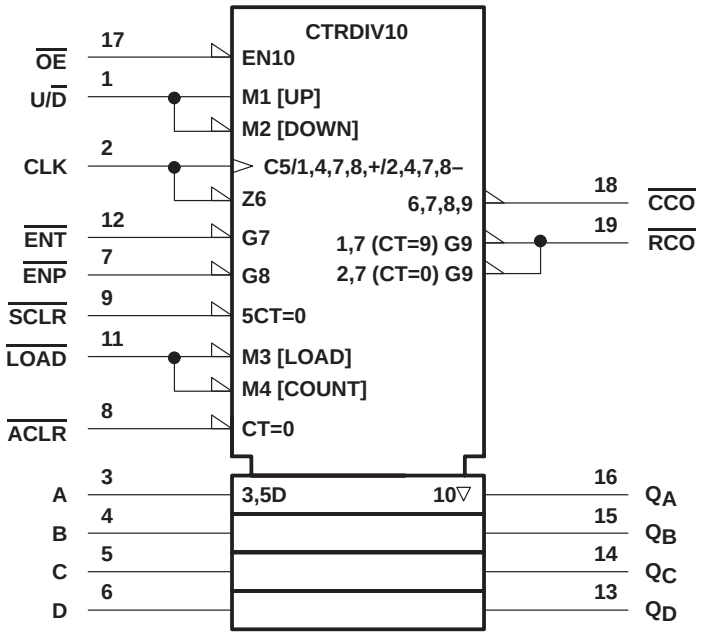
The SN54ALS569A is characterized for operation over the full military temperature range of –55°C to 125°C. The SN74ALS568A and SN74ALS569A are characterized for operation from 0°C to 70°C.

FUNCTION TABLE

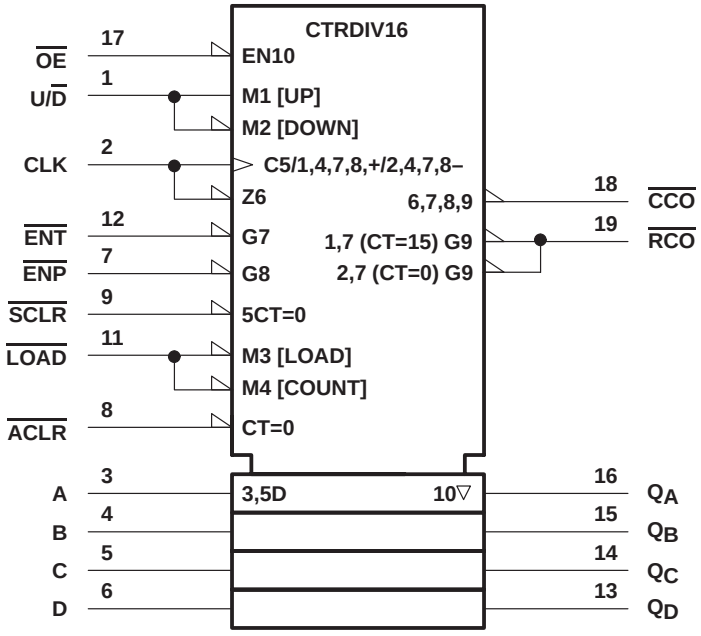
INPUTS								OPERATION
$\overline{OE}$	$\overline{ACLR}$	$\overline{SCLR}$	$\overline{LOAD}$	$\overline{ENT}$	$\overline{ENP}$	U/$\overline{D}$	CLK	
H	X	X	X	X	X	X	X	Q outputs disabled
L	L	X	X	X	X	X	X	Asynchronous clear
L	H	L	X	X	X	X	↑	Synchronous clear
L	H	H	L	X	X	X	↑	Load
L	H	H	H	L	L	H	↑	Count up
L	H	H	H	L	L	L	↑	Count down
L	H	H	H	H	X	X	X	Inhibit count
L	H	H	H	X	H	X	X	Inhibit count

logic symbols†

SN74ALS568A



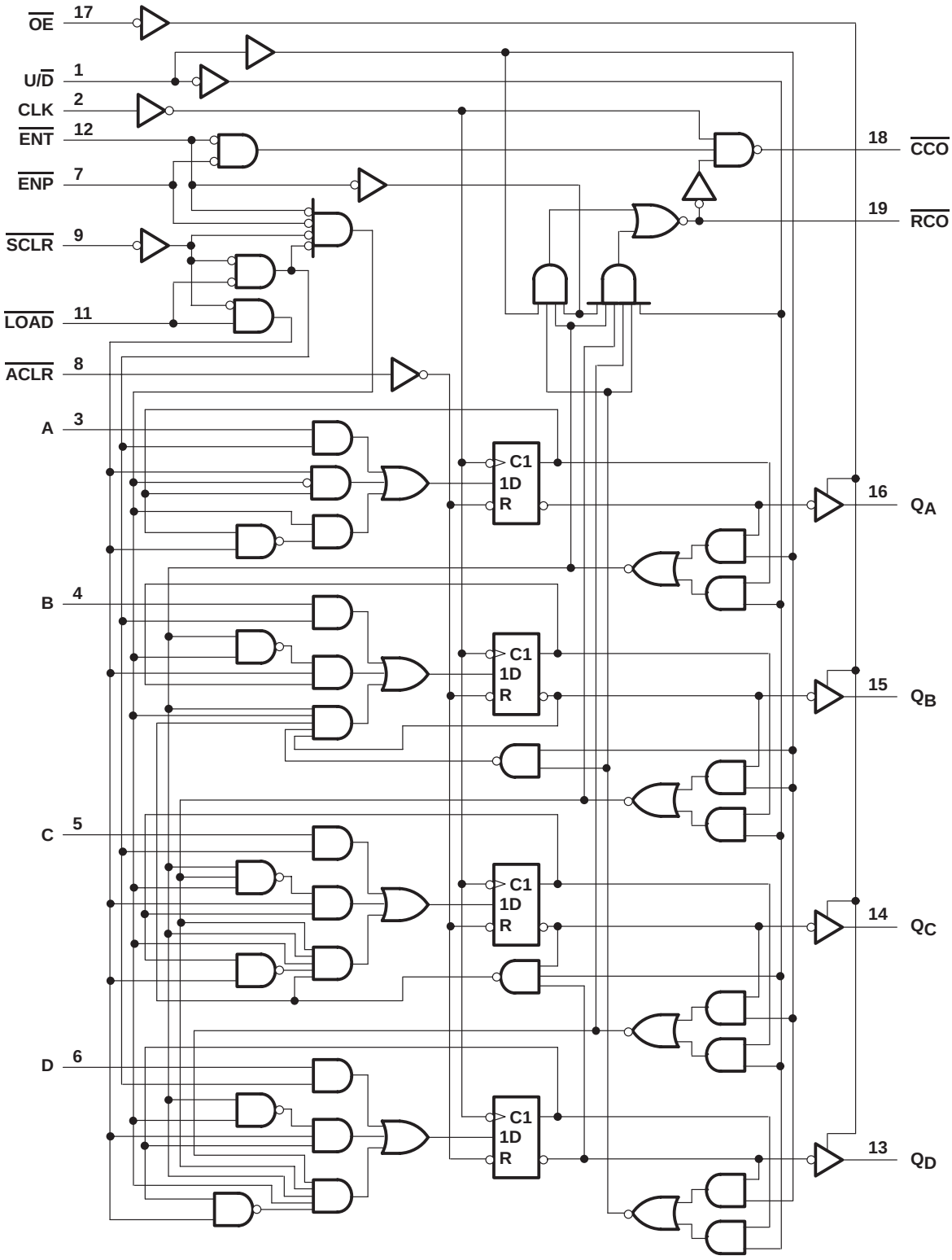
′ALS569A



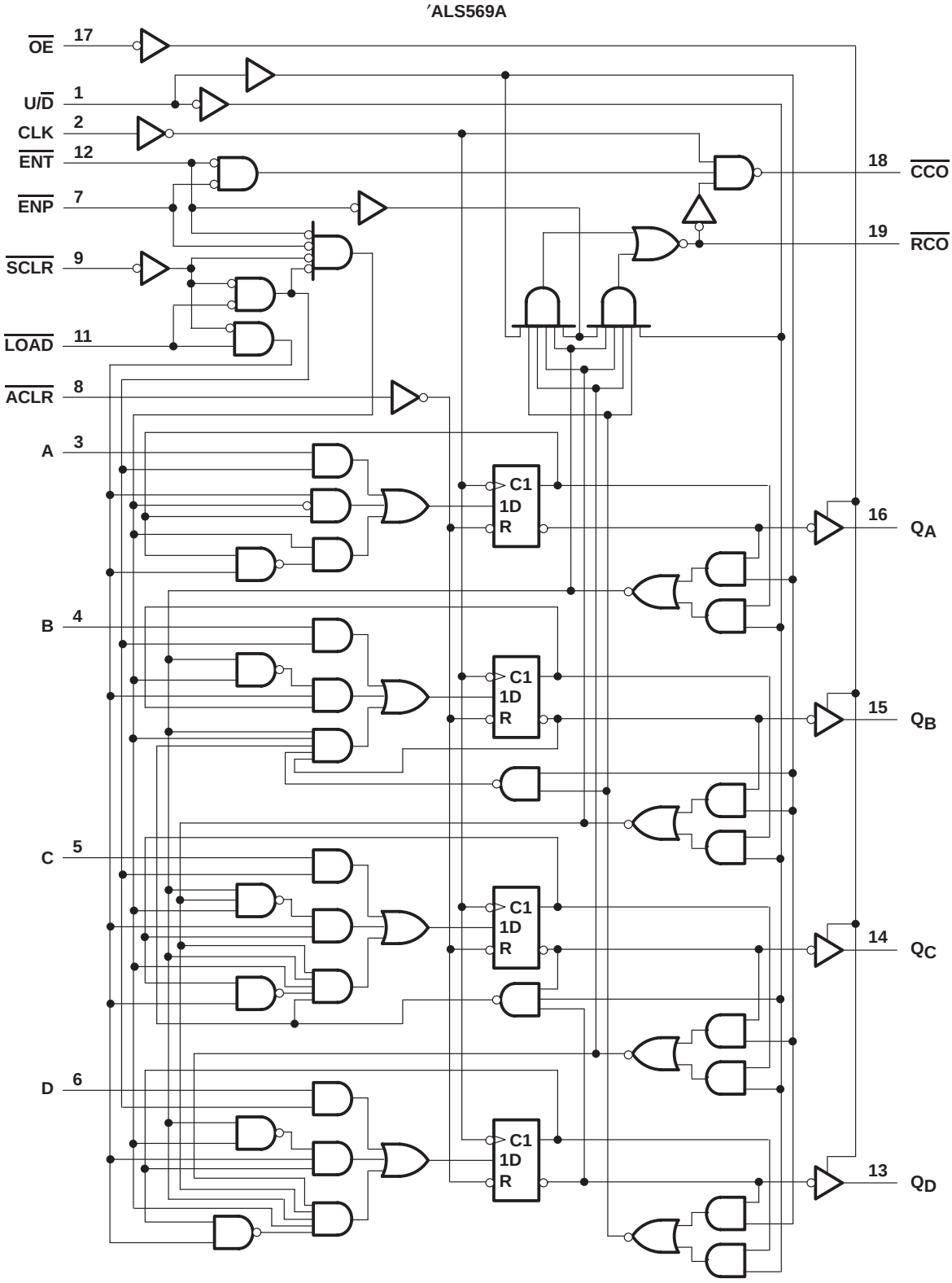
† These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

logic diagrams (positive logic)

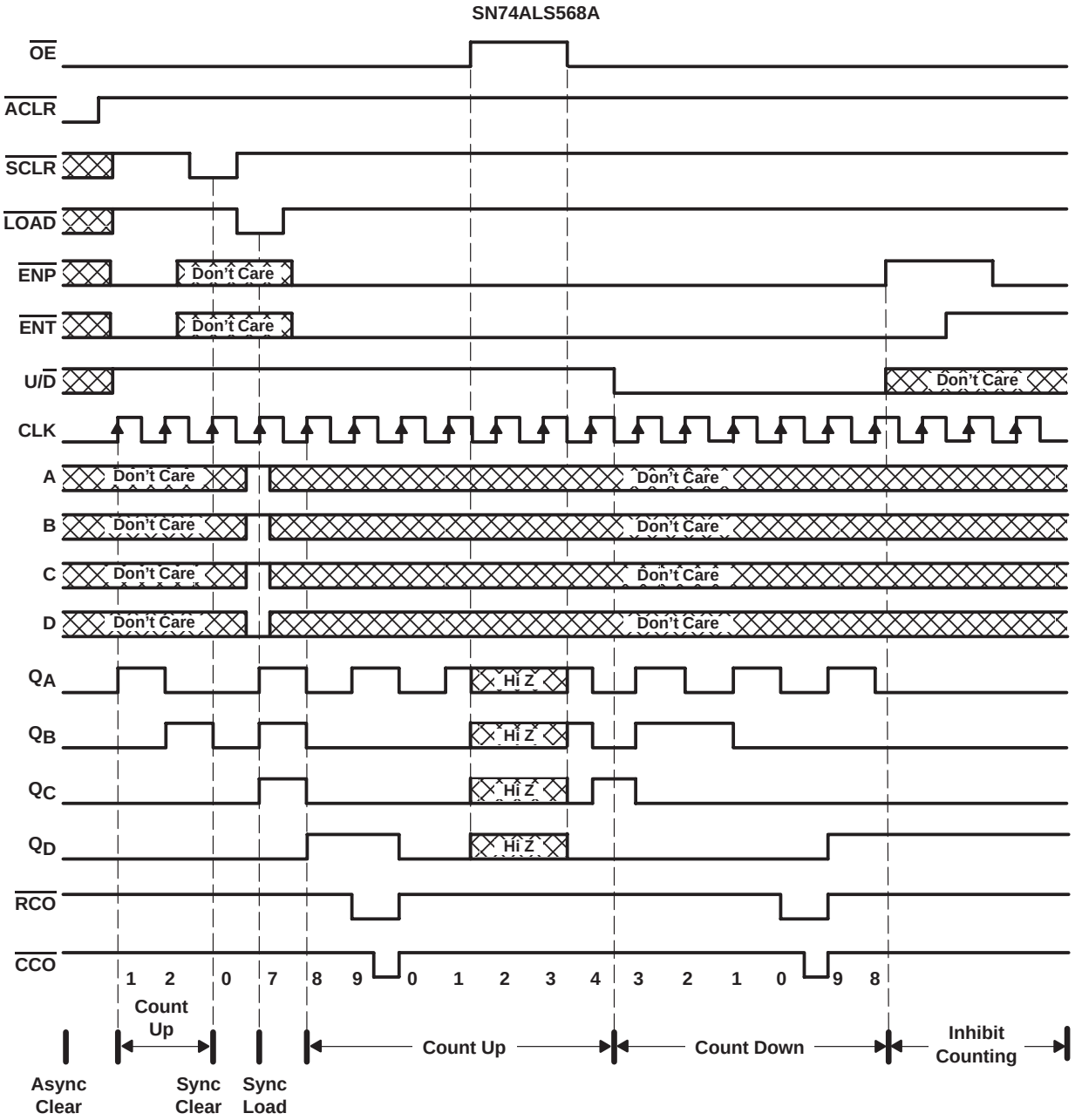
SN74ALS568A



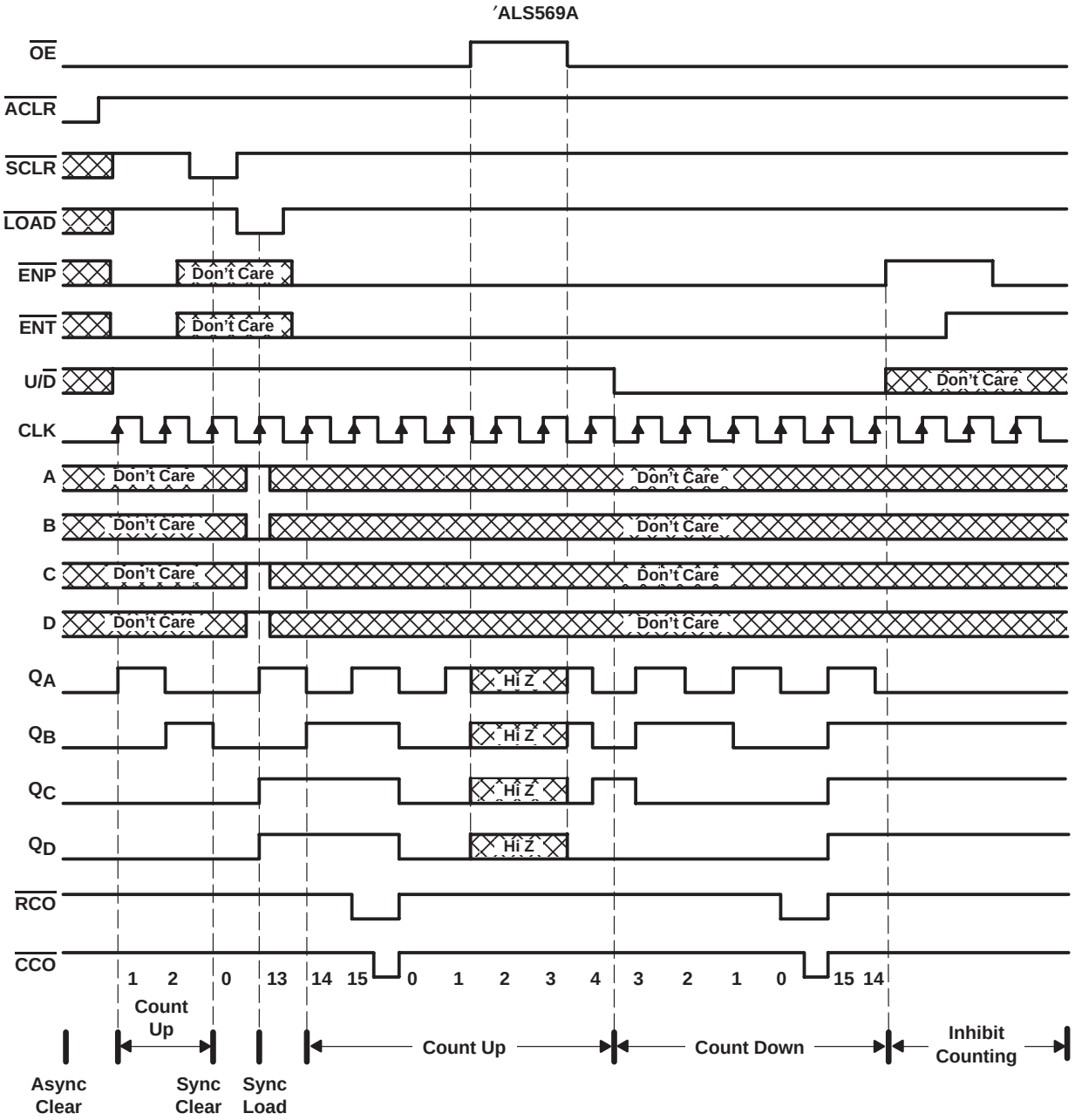
logic diagrams (positive logic) (continued)



typical load, count, and inhibit sequences



typical load, count, and inhibit sequences (continued)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V_{CC} . . . . . 7 V
Input voltage, V_I . . . . . 7 V
Voltage applied to a disabled 3-state output . . . . . 5.5 V
Operating free-air temperature range, T_A: SN54ALS569A . . . . . –55°C to 125°C
SN74ALS568A, SN74ALS569A . . . . . 0°C to 70°C
Storage temperature range . . . . . –65°C to 150°C

† Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

recommended operating conditions

				SN54ALS569A			SN74ALS568A SN74ALS569A			UNIT
				MIN	NOM	MAX	MIN	NOM	MAX	
V_{CC}	Supply voltage			4.5	5	5.5	4.5	5	5.5	V
V_{IH}	High-level input voltage			2			2			V
V_{IL}	Low-level input voltage					0.7			0.8	V
I_{OH}	High-level output current	Q outputs				–1			–2.6	mA
		$\overline{CCO}$ and $\overline{RCO}$				–0.4			–0.4	
I_{OL}	Low-level output current	Q outputs				12			24	mA
		$\overline{CCO}$ and $\overline{RCO}$				4			8	
f_{clock}	Clock frequency	SN74ALS568A					0		20	MHz
		′ALS569A		0		22	0		30	
t_w	Pulse duration	$\overline{ACLR}$ or $\overline{LOAD}$ low		20			15			ns
		SN74ALS568A	CLK high				25			
			CLK low				25			
		′ALS569A	CLK high	20			16.5			
			CLK low	23			16.5			
t_{su}	Setup time before CLK↑	Data at A, B, C, D		25			20			ns
		$\overline{ENP}$, $\overline{ENT}$	High	35			30			
			Low	25			20			
		$\overline{SCLR}$	Low	20			15			
			High (inactive)	35			30			
		$\overline{LOAD}$	Low	20			15			
			High (inactive)	35			30			
		U/$\overline{D}$		35			30			
		$\overline{ACLR}$ inactive		10			10			
t_h	Hold time after CLK↑ for any input			0			0			ns
T_A	Operating free-air temperature			–55		125	0		70	°C

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER		TEST CONDITIONS		SN54ALS569A			SN74ALS568A SN74ALS569A			UNIT
				MIN	TYP†	MAX	MIN	TYP†	MAX	
V_{IK}		V_{CC} = 4.5 V,	I_I = –18 mA			–1.5			–1.5	V
V_{OH}	All outputs	V_{CC} = 4.5 V to 5.5 V,	I_{OH} = –0.4 mA	V_{CC} –2			V_{CC} –2			V
	Q outputs	V_{CC} = 4.5 V	I_{OH} = –1 mA	2.4	3.3					
			I_{OH} = –2.6 mA				2.4	3.2		
V_{OL}	Q outputs	V_{CC} = 4.5 V	I_{OL} = 12 mA		0.25	0.4		0.25	0.4	V
			I_{OL} = 24 mA					0.35	0.5	
	$\overline{CCO}$ and $\overline{RCO}$	V_{CC} = 4.5 V	I_{OL} = 4 mA		0.25	0.4		0.25	0.4	
			I_{OL} = 8 mA					0.35	0.5	
I_{OZH}		V_{CC} = 5.5 V,	V_O = 2.7 V			20			20	µA
I_{OZL}		V_{CC} = 5.5 V,	V_O = 0.4 V			–20			–20	µA
I_I		V_{CC} = 5.5 V,	V_I = 7 V			0.1			0.1	mA
I_{IH}		V_{CC} = 5.5 V,	V_I = 2.7 V			20			20	µA
I_{IL}		V_{CC} = 5.5 V,	V_I = 0.4 V			–0.2			–0.2	mA
I_O‡	$\overline{CCO}$ and $\overline{RCO}$	V_{CC} = 5.5 V,	V_O = 2.25 V	–15		–70	–15		–70	mA
	Q outputs			–20		–112	–30		–112	
I_{CC}		V_{CC} = 5.5 V	Outputs high		16	26		16	26	mA
			Outputs low		20	32		20	32	
			Outputs disabled		20	32		20	32	

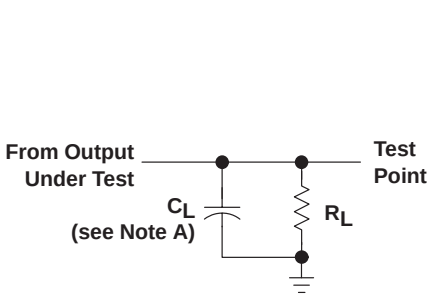
† All typical values are at V_{CC} = 5 V, T_A = 25°C.
‡ The output conditions have been chosen to produce a current that closely approximates one half of the true short-circuit output current, I_{OS}.

switching characteristics (see Figure 1)

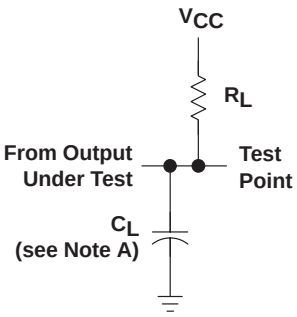
PARAMETER	FROM (INPUT)	TO (OUTPUT)	V_{CC} = 4.5 V to 5.5 V, C_L = 50 pF, R1 = 500 Ω, R2 = 500 Ω, T_A = MIN to MAX†				UNIT
			SN54ALS569A		SN74ALS568A SN74ALS569A		
			MIN	MAX	MIN	MAX	
f_{max}	SN74ALS568A				20		MHz
	′ALS569A		22		30		
t_{PLH}	CLK	Any Q	4	21	4	13	ns
t_{PHL}			7	19	7	16	
t_{PLH}	CLK	$\overline{RCO}$	12	37	12	28	ns
t_{PHL}			10	28	10	19	
t_{PLH}	CLK	$\overline{CCO}$	5	17	5	13	ns
t_{PHL}			6	30	6	25	
t_{PLH}	U/$\overline{D}$	$\overline{RCO}$	9	31	9	23	ns
t_{PHL}			9	33	9	19	
t_{PLH}	$\overline{ENT}$	$\overline{RCO}$	6	21	6	15	ns
t_{PHL}			4	20	4	13	
t_{PLH}	$\overline{ENT}$	$\overline{CCO}$	5	18	5	13	ns
t_{PHL}			9	32	9	23	
t_{PLH}	$\overline{ENP}$	$\overline{CCO}$	4	18	4	12	ns
t_{PHL}			5	18	5	14	
t_{PHL}	$\overline{ACLR}$	Any Q	9	25	9	20	ns
t_{PZH}	$\overline{OE}$	Any Q	6	23	6	18	ns
t_{PZL}			6	29	6	24	
t_{PHZ}	$\overline{OE}$	Any Q	1	12	1	10	ns
t_{PLZ}			3	29	3	13	

† For conditions shown as MIN or MAX, use the appropriate value specified under recommended operating conditions.

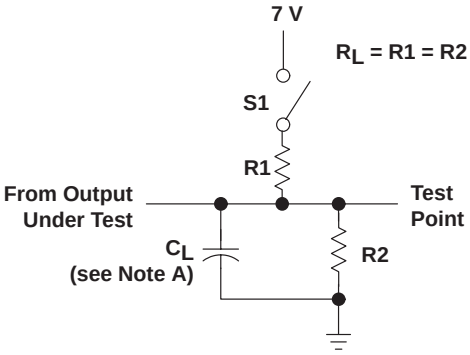
PARAMETER MEASUREMENT INFORMATION
SERIES 54ALS/74ALS AND 54AS/74AS DEVICES



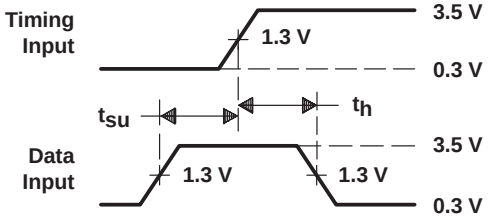
LOAD CIRCUIT FOR
BI-STATE
TOTEM-POLE OUTPUTS



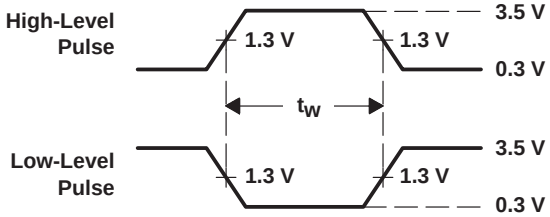
LOAD CIRCUIT
FOR OPEN-COLLECTOR OUTPUTS



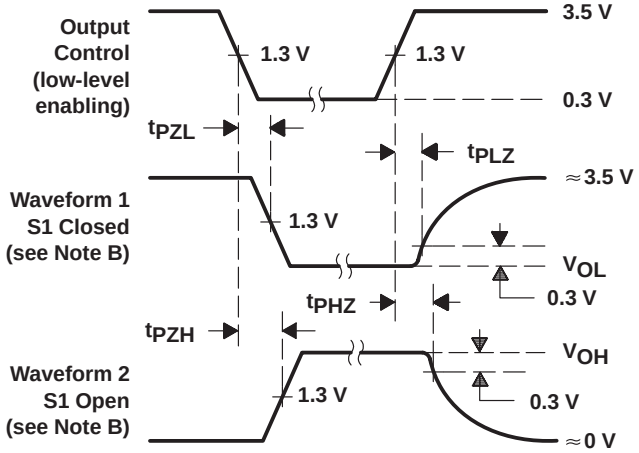
LOAD CIRCUIT
FOR 3-STATE OUTPUTS



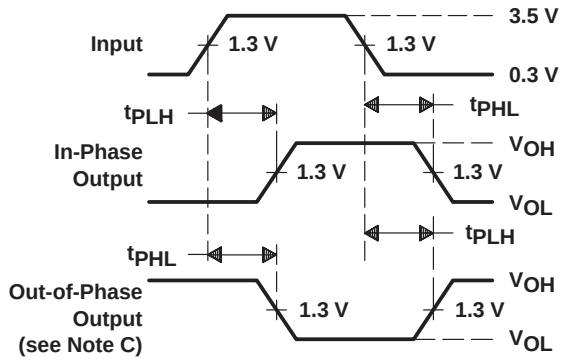
VOLTAGE WAVEFORMS
SETUP AND HOLD TIMES



VOLTAGE WAVEFORMS
PULSE DURATIONS



VOLTAGE WAVEFORMS
ENABLE AND DISABLE TIMES, 3-STATE OUTPUTS



VOLTAGE WAVEFORMS
PROPAGATION DELAY TIMES

NOTES: A. C_L includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
C. When measuring propagation delay items of 3-state outputs, switch S1 is open.
D. All input pulses have the following characteristics: PRR ≤ 1 MHz, $t_r = t_f$ = 2 ns, duty cycle = 50%.
E. The outputs are measured one at a time with one transition per measurement.

Figure 1. Load Circuits and Voltage Waveforms

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